# **MOSFET** -

# POWERTRENCH<sup>®</sup>, N-Channel, DUAL COOL<sup>®</sup>, Shielded Gate 150 V, 40 A, 17mΩ

# **FDMS86200DC**

#### **General Description**

This N-Channel MOSFET is produced using **onsemi**'s advanced POWERTRENCH® process that incorporates Shielded Gate technology. Advancements in both silicon and DUAL COOL® package technologies have been combined to offer the lowest  $r_{DS(on)}$  while maintaining excellent switching performance by extremely low Junction-to-Ambient thermal resistance.

#### **Features**

- Shielded Gate MOSFET Technology
- DUAL COOL® Top Side Cooling DFN8 Package
- Max  $r_{DS(on)} = 17 \text{ m}\Omega$  at  $V_{GS} = 10 \text{ V}$ ,  $I_D = 9.3 \text{ A}$
- Max  $r_{DS(on)} = 25 \text{ m}\Omega$  at  $V_{GS} = 6 \text{ V}$ ,  $I_D = 7.8 \text{ A}$
- High Performance Technology for Extremely Low r<sub>DS(on)</sub>
- 100% UIL Tested
- RoHS Compliant

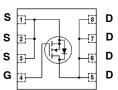
# **Applications**

- Primary MOSFET in DC DC Converters
- Secondary Synchronous Rectifier
- Load Switch

#### MOSFET MAXIMUM RATINGS (T<sub>A</sub> = 25°C unless otherwise noted)

Symbol	Parameter	Ratings	Unit
V <sub>DS</sub>	Drain to Source Voltage	150	V
V <sub>GS</sub>	Gate to Source Voltage	±20	V
I <sub>D</sub>	Drain Current: Continuous, T <sub>C</sub> = 25°C Continuous, T <sub>A</sub> = 25°C (Note 1a) Pulsed (Note 4)	40 9.3 100	Α
E <sub>AS</sub>	Single Pulse Avalanche Energy (Note 3)	294	mJ
P <sub>D</sub>	Power Dissipation: T <sub>C</sub> = 25°C T <sub>A</sub> = 25°C (Note 1a)	125 3.2	W
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Junction Temperature Range	-55 to +150	°C

#### **ELECTRICAL CONNECTION**

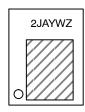


**N-Channel MOSFET** 



DFN8, DUAL COOL®
CASE 506EG

#### **MARKING DIAGRAM**



2J = Specific Device Code A = Assembly Location

Y = Year W = Work Week

Z = Assembly Lot Code

#### **ORDERING INFORMATION**

See detailed ordering and shipping information on page 2 of this data sheet.

**Table 1. THERMAL CHARACTERISTICS** 

Symbol	Characteristic	Value	Unit
$R_{ heta JC}$	Thermal Resistance, Junction to Case (Top Source)	2.5	
$R_{ heta JC}$	Thermal Resistance, Junction to Case (Bottom Drain)	1.0	
$R_{ heta JA}$	Thermal Resistance, Junction to Ambient (Note 1a)	38	
$R_{ heta JA}$	Thermal Resistance, Junction to Ambient (Note 1b)	81	°C/W
$R_{ heta JA}$	Thermal Resistance, Junction to Ambient (Note 1i)	16	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Note 1j)	23	
$R_{ hetaJA}$	Thermal Resistance, Junction to Ambient (Note 1k)	11	

# ORDERING INFORMATION AND PACKAGE MARKING

Device	Top Marking	Package	Reel Size	Tape Width	Shipping <sup>†</sup>
FDMS86200DC	2J	DFN8	13″	12 mm	3000 Units/ Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

# **ELECTRICAL CHARACTERISTICS** ( $T_J = 25^{\circ}C$ unless otherwise noted)

Symbol	Parameter	Test Condition	Min	Тур	Max	Unit	
OFF CHAR	ACTERISTICS		•				
BVDSS	Drain to Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	150			V	
ΔBV <sub>DSS</sub> /ΔT <sub>J</sub>	Breakdown Voltage Temperature Coefficient	I <sub>D</sub> = 250 μA, referenced to 25°C		105		mV/°C	
IDSS	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 120 V, V <sub>GS</sub> = 0 V			1	μΑ	
Igss	Gate to Source Leakage Current	V <sub>GS</sub> = ±20 V, V <sub>DS</sub> = 0 V			±100	nA	
ON CHARA	CTERISTICS						
V <sub>GS(th)</sub>	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = 250 \mu A$	2.0	3.3	4.0	V	
$\Delta V_{GS(th)}$ / $\Delta T_J$	Gate to Source Threshold Voltage Temperature Coefficient	I <sub>D</sub> = 250 μA, referenced to 25 °C		-11		mV/°C	
		V <sub>GS</sub> = 10 V, I <sub>D</sub> = 9.3 A		14	17		
r <sub>DS(on)</sub>	Static Drain to Source On Resistance	V <sub>GS</sub> = 6 V, I <sub>D</sub> = 7.8 A		17	25	mΩ	
· D3(0II)		V <sub>GS</sub> = 10 V, I <sub>D</sub> = 9.3 A, T <sub>J</sub> = 125 °C		29	35	- 11122	
9 <sub>FS</sub>	Forward Transconductance	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 9.3 A		32		S	
DYNAMIC C	HARACTERISTICS						
C <sub>iss</sub>	Input Capacitance			2110	2955	pF	
C <sub>oss</sub>	Output Capacitance	V <sub>DS</sub> = 75 V, V <sub>GS</sub> = 0 V, f = 1 MHz		205	290	pF	
C <sub>rss</sub>	Reverse Transfer Capacitance	I = 1 WINZ		8.1	15	pF	
R <sub>g</sub>	Gate Resistance		0.1	1.5	3.0	Ω	
SWITCHING	CHARACTERISTICS						
t <sub>d(on)</sub>	Turn-On Delay Time			16	29	ns	
t <sub>r</sub>	Rise Time	V <sub>DD</sub> = 75 V, I <sub>D</sub> = 9.3 A, V <sub>GS</sub> = 10 V,		4	10	ns	
t <sub>d(off)</sub>	Turn-Off Delay Time	$R_{GEN} = 6 \Omega$		23	37	ns	
t <sub>f</sub>	Fall Time			5	10	ns	

# **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = 25°C unless otherwise noted) (continued)

Symbol	Parameter	Test Condition	Min	Тур	Max	Unit
0	Tatal Cata Chausa	$V_{GS}$ = 0 V to 10 V, $V_{DD}$ = 75 V, $I_D$ = 9.3 A		30	42	nC
$Q_g$	Total Gate Charge	V <sub>GS</sub> = 0 V to 5 V, V <sub>DD</sub> = 75 V, I <sub>D</sub> = 9.3 A		19	27	nC
Q <sub>gs</sub>	Gate to Source Charge	V 75 V L 0.2 A		9.7		nC
Q <sub>gd</sub>	Gate to Drain "Miller" Charge	V <sub>DD</sub> = 75 V, I <sub>D</sub> = 9.3 A		5.6		nC

#### **DRAIN-SOURCE DIODE CHARACTERISTICS**

		$V_{GS} = 0 \text{ V}, I_S = 9.3 \text{ A (Note 2)}$	0.8	1.3	
VsD	Source to Drain Diode Forward Voltage	V <sub>GS</sub> = 0 V, I <sub>S</sub> = 2.6 A (Note 2)	0.7	1.2	V
t <sub>rr</sub>	Reverse Recovery Time		79	126	ns
Q <sub>rr</sub>	Reverse Recovery Charge	I <sub>F</sub> = 9.3 A, di/dt = 100 A/μs	126	176	nC

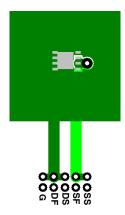
Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

#### RECOMMENDED OPERATING CONDITIONS

Symbol	Parameter		Max	Unit
Rejc	Thermal Resistance, Junction to Case	(Top Source)	2.5	
Rejc	Thermal Resistance, Junction to Case	(Bottom Drain)	1.0	
Reja	Thermal Resistance, Junction to Ambient	(Note 1a)	38	
Reja	Thermal Resistance, Junction to Ambient	(Note 1b)	81	
Reja	Thermal Resistance, Junction to Ambient	(Note 1c)	27	
RθJA	Thermal Resistance, Junction to Ambient	(Note 1d)	34	
Reja	Thermal Resistance, Junction to Ambient	(Note 1e)	16	0000
RеJA	Thermal Resistance, Junction to Ambient	(Note 1f)	19	°C/W
Reja	Thermal Resistance, Junction to Ambient	(Note 1g)	26	
Reja	Thermal Resistance, Junction to Ambient	(Note 1h)	61	
RеJA	Thermal Resistance, Junction to Ambient	(Note 1i)	16	
Reja	Thermal Resistance, Junction to Ambient	(Note 1j)	23	
Reja	Thermal Resistance, Junction to Ambient	(Note 1k)	11	
Reja	Thermal Resistance, Junction to Ambient	(Note 1I)	13	

<sup>1.</sup>  $R_{\theta JA}$  is determined with the device mounted on a 1 in<sup>2</sup> pad 2 oz copper pad on a 1.5 × 1.5 in. board of FR-4 material.  $R_{\theta CA}$  is determined by the user's board design.

NOTES:  $R_{\theta,JA}$  is determined with the device mounted on a 1 in<sup>2</sup> pad 2 oz copper pad on a 1.5  $\times$  1.5 in. board of FR-4 material.  $R_{\theta CA}$  is determined by the user's board design.



 a) 38°C/W when mounted on a 1 in<sup>2</sup> pad of 2 oz copper.



b) 81°C/W when mounted on a 1 in<sup>2</sup> pad of 2 oz copper.

- c) Still air, 20.9x10.4x12.7mm Aluminum Heat Sink, 1 in<sup>2</sup> pad of 2 oz copper
- d) Still air, 20.9x10.4x12.7mm Aluminum Heat Sink, minimum pad of 2 oz copper
- e) Still air, 45.2x41.4x11.7mm Aavid Thermalloy Part # 10-L41B-11 Heat Sink, 1 in<sup>2</sup> pad of 2 oz copper
- f) Still air, 45.2x41.4x11.7mm Aavid Thermalloy Part # 10-L41B-11 Heat Sink, minimum pad of 2 oz copper
- g) 200FPM Airflow, No Heat Sink,1 in<sup>2</sup> pad of 2 oz copper
- h) 200FPM Airflow, No Heat Sink, minimum pad of 2 oz copper
- i) 200FPM Airflow, 20.9x10.4x12.7mm Aluminum Heat Sink, 1 in<sup>2</sup> pad of 2 oz copper
- j) 200FPM Airflow, 20.9x10.4x12.7mm Aluminum Heat Sink, minimum pad of 2 oz copper
- k) 200FPM Airflow, 45.2x41.4x11.7mm Aavid Thermalloy Part # 10-L41B-11 Heat Sink, 1 in<sup>2</sup> pad of 2 oz copper
- l) 200FPM Airflow, 45.2x41.4x11.7mm Aavid Thermalloy Part # 10-L41B-11 Heat Sink, minimum pad of 2 oz copper
- 2. Pulse Test: Pulse Width < 300  $\mu$ s, Duty cycle < 2.0%.
- 3.  $E_{AS}$  of 294 mJ is based on starting  $T_J$  = 25°C; N-ch: L = 3 mH,  $I_{AS}$  = 14 A,  $V_{DD}$  = 150 V.  $V_{GS}$  = 10 V, 100% tested at L = 0.3 mH,  $I_{AS}$  = 31 A.
- 4. Pulsed Id limited by junction temperature, td <= 10 μs, please refer to SOA curve for more details.

#### **TYPICAL CHARACTERISTICS**

(T<sub>J</sub> = 25°C UNLESS OTHERWISE NOTED)

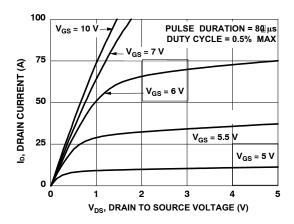


Figure 1. On-Region Characteristics

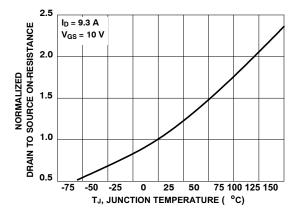


Figure 3. Normalized On-Resistance vs. Junction Temperature

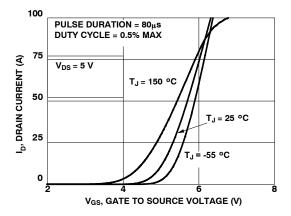


Figure 5. Transfer Characteristics

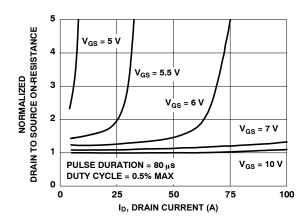


Figure 2. Normalized On-Resistance vs. Drain Current and Gate Voltage

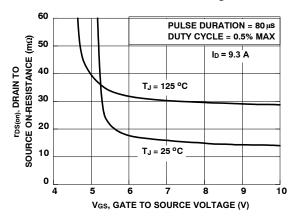


Figure 4. On-Resistance vs. Gate to Source Voltage

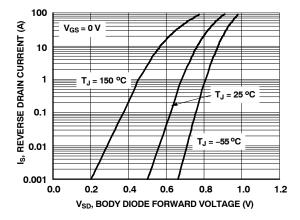


Figure 6. Source to Drain Diode Forward Voltage vs. Source Current

#### **TYPICAL CHARACTERISTICS (CONTINUED)**

(T<sub>J</sub> = 25°C UNLESS OTHERWISE NOTED)

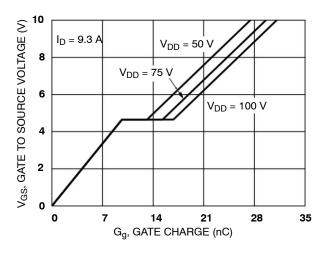


Figure 7. Gate Charge Characteristics

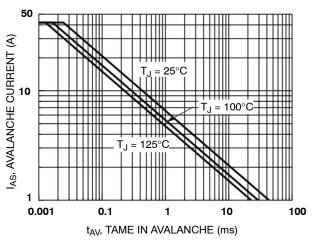


Figure 9. Unclamped Inductive Switching Capability

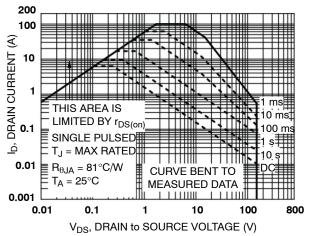


Figure 11. Forward Bias Safe Operating Area

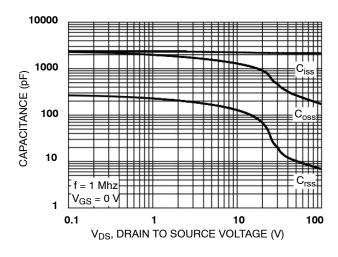


Figure 8. Capacitance vs Drain to Source Voltage

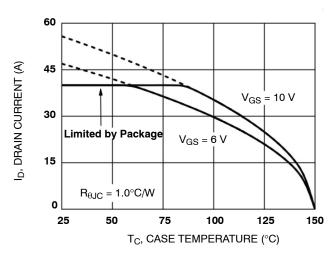


Figure 10. Maximum Continuous Drain Current vs Case Temperature

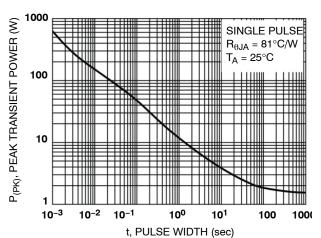


Figure 12. Single Pulse Maximum Power Dissipation

# **TYPICAL CHARACTERISTICS (CONTINUED)**

(T<sub>J</sub> = 25°C UNLESS OTHERWISE NOTED)

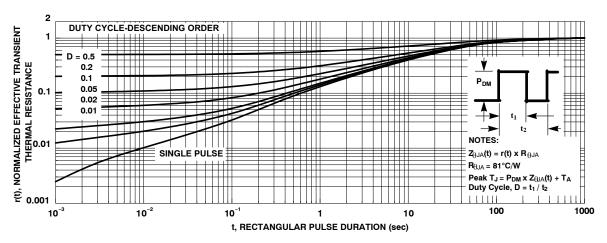
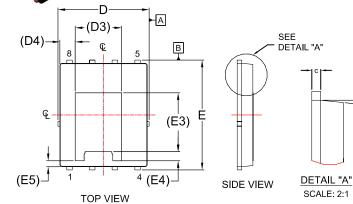


Figure 13. Junction-to-Ambient Transient Thermal Response Curve

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#### DFN8 5x6.15, 1.27P, DUAL COOL CASE 506EG ISSUE D

**DATE 25 AUG 2020** 



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| E1

#### NOTES:

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- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2009.
- 2. CONTROLLING DIMENSION: MILLIMETERS
- 3. COPLANARITY APPLIES TO THE EXPOSED PADS AS WELL AS THE TERMINALS.
- 4. DIMENSIONS D1 AND E1 DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR GATE BURRS.
- 5. SEATING PLANE IS DEFINED BY THE TERMINALS. "A1" IS DEFINED AS THE DISTANCE FROM THE SEATING PLANE TO THE LOWEST POINT ON THE PACKAGE BODY.

FRONT VIEW SEE DETAIL "B"	8X 0.10 C	A2	-Θ 	SEATING PLANE
	AB	DETAIL "B" SCALE: 2:1	C	
e b1 (8X) -b (4X)	0 77			

0. <del>77</del>	5.10 3.91 8 7 6 5
3.75	6.61
1.27 1.27-	

RECOMMENDATION
\*FOR ADDITIONAL INFORMATION ON OUR

PB-FREE STRATEGY AND SOLDERING DETAILS, PLEASE DOWNLOAD THE ON SEMICONDUCTOR SOLDERING AND MOUNTING TECHNIQUES REFERENCE MANUAL, SOLDERRM/D.

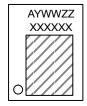
D <b>i</b> M	MILLIMETERS			
Diw	MIN.	NOM.	MAX.	
Α	0.85	0.90	0.95	
A1	-	-	0.05	
A2	ı	-	0.05	
р	0.31	0.41	0.51	
b1	0.21	0.31	0.41	
C	0.20	0.25	0.30	
D	4.90	5.00	5.10	
D1	4.80	4.90	5.00	
D2	3.67	3.82	3.97	
D3		2.60 RE	F	
D4		0.86 REI	F	
Е	6.05	6.15	6.25	
E1	5.70	5.80	5.90	
E2	3.38	3.48	3.58	
E3	•	3.30 REF	-	
E4		0.50 REF	•	
E5	(	0.34 REF	:	
E6	(	0.30 REF	:	
E7	(	0.52 REF	:	
е	1	1.27 BSC	:	
1/2e	0	.635 BS0	C	
K	1.30	1.40	1.50	
L	0.56	0.66	0.76	
L1	0.52	0.62	0.72	
θ	0°		12°	

# GENERIC MARKING DIAGRAM\*

D1

**BOTTOM VIEW** 

(E6)



XXXX = Specific Device Code

A = Assembly Location

Y = Year

WW = Work Week

ZZ = Assembly Lot Code

\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "•", may or may not be present. Some products may not follow the Generic Marking.

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DESCRIPTION:	DFN8 5x6.15, 1.27P, DUAL	DFN8 5x6.15, 1.27P, DUAL COOL	

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